

FDZ5047N

30V N-Channel Logic Level PowerTrench® BGA MOSFET

General Description

Combining Fairchild's 30V PowerTrench process with state of the art BGA packaging, the FDZ5047N minimizes both PCB space and $R_{\rm DS(ON)}.$ This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low $R_{\rm DS(ON)}.$

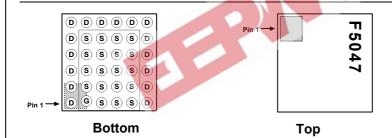
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS(ON)}}$ specifications resulting in DC/DC power supply designs with higher overall efficiency.

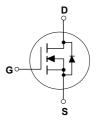
Applications

- DC/DC converters
- · Solenoid drive

Features

- 22 A, 30 V. $R_{DS(ON)}$ = 2.9 m Ω @ V_{GS} = 10 V $R_{DS(ON)}$ = 4.5 m Ω @ V_{GS} = 4.5 V
- Occupies only 27.5 mm² of PCB area:
 1/5 of the area of a TO-220 package
- Ultra-thin package: less than 0.90 mm height when mounted to PCB
- Outstanding thermal transfer characteristics
- Ultra-low gate charge x R_{DS(ON)} product





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V _{DSS}	Drain-Source Voltage	30	V
V _{GSS}	Gate-Source Voltage	±20	
I _D	Drain Current - Continuous (Note 1a)	22	Α
	– Pulsed	75	
P _D	Total Power Dissipation @ T _A = 25°C	2.8	W
T_J , T_{STG}	Operating and Storage Junction Temperature Range	-50 to +150	°C

Thermal Characteristics

R _{θJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	44	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Ball	(Note 1)	2.7	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	0.3	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
5047N	FDZ5047N	13"	12mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics	1	1			
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	30		İ	V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C		24		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μΑ
GSSF	Gate-Body Forward Leakage	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
GSSR	Gate–Body Reverse Leakage	V _{GS} = -20 V, V _{DS} = 0 V			-100	nA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1	1.3	3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C		– 5		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, I_D = 22 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 18 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 22 \text{ A}, T_A = 125 ^{\circ}\text{C}$		2.3 3.2 3.4	2.9 4.5 5.0	mΩ
] FS	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 22 \text{ A}$	3_	100		S
Dynamic	Characteristics	4.16	D			
Ciss	Input Capacitance	$V_{DS} = 15 \text{ V}, \qquad V_{GS} = 0 \text{ V},$	-40	4993		pF
Coss	Output Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz	-	1144		pF
C _{rss}	Reverse Transfer Capacitance	4 3		498		pF
Switchin	g Characteristics (Note 2)	CO.				
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, \qquad I_D = 1 \text{ A},$		11	20	ns
·r	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		12	22	ns
d(off)	Turn-Off Delay Time			119	190	ns
f	Turn-Off Fall Time			55	88	ns
\mathfrak{I}^{g}	Total Gate Charge	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 22 \text{ A},$		52	73	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 5 V		11		nC
Q_{gd}	Gate-Drain Charge			17		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
l _s	Maximum Continuous Drain-Source	e Diode Forward Current (Note 1a)			2.3	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.3 \text{ A}$ (Note 2)		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 22A,		42		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$		59		nC

^{1.} $R_{0,JA}$ is determined with the device mounted on a 1 in² 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, $R_{0,JB}$, is defined for reference. For $R_{0,JC}$, the thermal reference point for the case is defined as the top surface of the copper chip carrier. $R_{0,JC}$ and $R_{0,JB}$ are guaranteed by design while $R_{0,JA}$ is determined by the user's board design.



a) 44°C/W when mounted on a 1in² pad of 2 oz copper

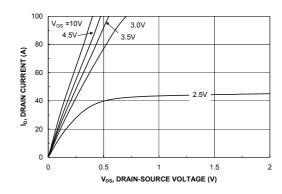


b) 95°C/W when mounted on a minimum pad of 2 oz copper

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300μ s, Duty Cycle < 2.0%

Typical Characteristics



2.6 | V_{GS} = 3.0V | V_{GS} = 3.0V | V_{GS} = 3.0V | V_{GS} = 3.5V |

Figure 1. On-Region Characteristics.

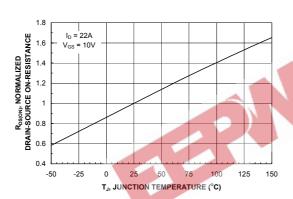


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

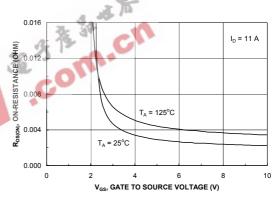


Figure 3. On-Resistance Variation with Temperature.

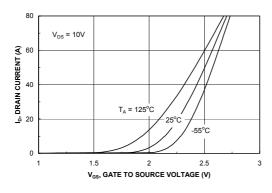


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

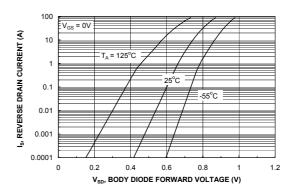
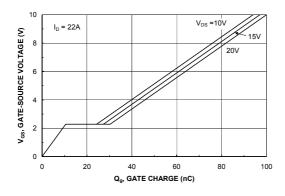


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



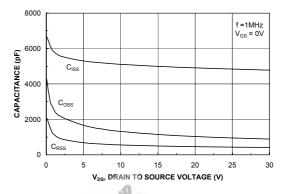


Figure 7. Gate Charge Characteristics.

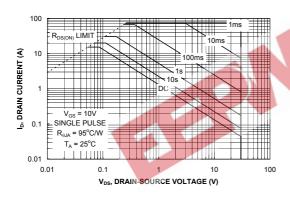


Figure 8. Capacitance Characteristics.

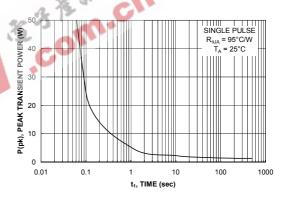


Figure 9. Maximum Safe Operating Area.



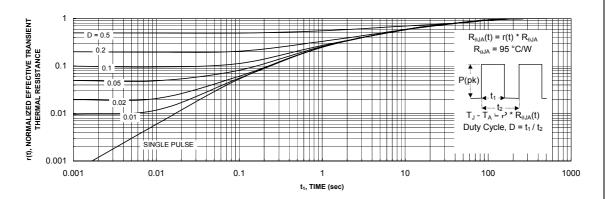
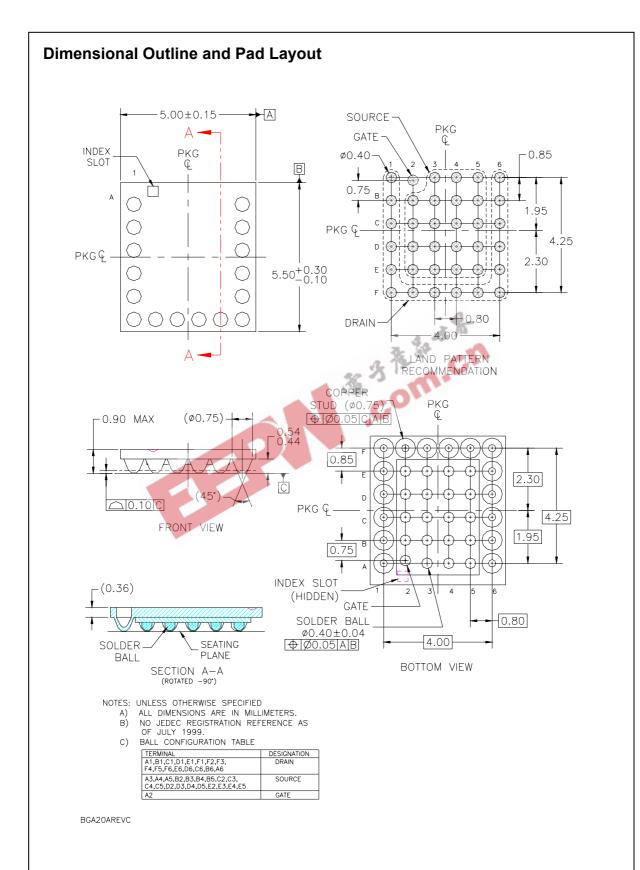


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.



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